

<b>Notice of References Cited</b>	Application/Control No. 10/617,522	Applicant(s)/Patent Under Reexamination CHEN, TERENCE	
	Examiner Debra S Meislin	Art Unit 3723	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-1,205,149	11-1916	Bovee	81/177.9
	B	US-6,131,490 A	10-2000	Lee, Grace	81/63.1
	C	US-6,286,396 B1	09-2001	Johnson, Mark P.	81/60
	D	US-6,412,373 B1	07-2002	Hsiao, Chieh-Jen	81/177.7
	E	US-6,412,374 B1	07-2002	Hsieh, Chih-Ching	81/177.7
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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